



Pullable Quartz Crystals

Features

 Provides Jitter Attenuation Function for the Following T1/E1 Line Interface Units

CS61304A, CS61305A, CS61535A, CS61574A, CS61575, CS61577

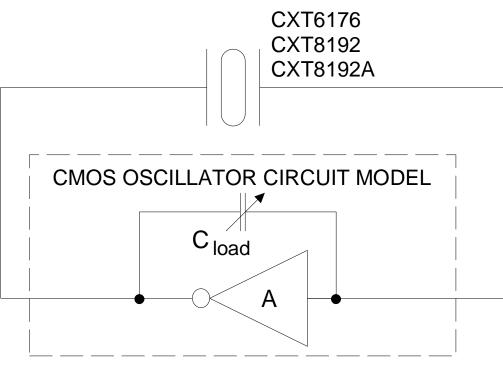
 Provides Jitter Attenuation Function for the CS61600 Jitter Attenuator

General Description

The CXT6176 and CXT8192 pullable quartz crystals ensure proper jitter attenuation and frequency tolerance for Crystal Semiconductor's line interface and jitter attenuator devices. The CXT6176 is designed for use in 1.544 MHz T1 applications and the CXT8192 is designed for use in 2.048 MHz E1 applications. The CXT8192A is a specialized tight tolerance crystal designed to meet the CTR12 jitter attenuation requirements for E1 applications when used with the CS61575, CS61304A, and CS61305A line interface devices.

ORDERING INFORMATION

CXT6176: HC-49 Package, -40 to +85 °C CXT6176U:HC-49U/N Package, -40 to +85 °C CXT8192: HC-49 Package, -40 to +85 °C CXT8192U:HC-49U/N Package, -40 to +85 °C CXT8192A:HC-49 Package, -40 to +85 °C



Crystal Line Interface or Jitter Attenuator Device

Preliminary Product Information

Crystal Semiconductor Corporation P.O. Box 17847, Austin, Texas 78760 (512) 445 7222 FAX: (512) 445 7581 http://www.crystal.com

Copyright © Crystal Semiconductor Corporation 1997 (All Rights Reserved)

This document contains information for a new product. Crystal

Semiconductor reserves the right to modify this product without notice.

CXT6176 Performance Specifications

Parameter		Min	Тур	Max	Units	
Total Frequency Range (Note 2		(Note 1)	-	370	390	ppm
Operating Frequency	C _{load} = 11.6 pF C _{load} = 19.0 pF C _{load} = 37.0 pF	(Note 2) (Note 3) (Note 2)	6.176803 6.175846 -	- 6.176000 -	- 6.176154 6.175197	MHz MHz MHz

CXT8192 Performance Specifications

Parameter			Min	Тур	Max	Units
Total Frequency Range		(Note 1)	-	210	245	ppm
Operating Frequency	C _{load} = 11.6 pF C _{load} = 19.0 pF C _{load} = 37.0 pF	(Note 2) (Note 3) (Note 2)	8.192410 8.191795 -	- 8.192000 -	- 8.192205 8.191590	MHz MHz MHz

CXT8192A Performance Specifications (Notes 4, 5)

Parameter		Min	Тур	Max	Units	
Total Frequency Range		(Note 1)	-	160	190	ppm
Operating Frequency	C _{load} = 11.6 pF C _{load} = 19.0 pF C _{load} = 37.0 pF	(Note 2) (Note 3) (Note 2)	8.192410 8.191795 -	- 8.192000 -	- 8.192205 8.191590	MHz MHz MHz

Notes: 1. With C_{load} varying from 11.6 to 37.0 pF at a given temperature.

2. Measured at -40 to 85 °C.

3. Measured with Saunders 150D meter at 25 °C.

4. The CXT8192A crystal is designed to meet CTR12 jitter attenuation requirements for E1 applications when used with the CS61575, CS61304A, and CS61305A line interface devices.

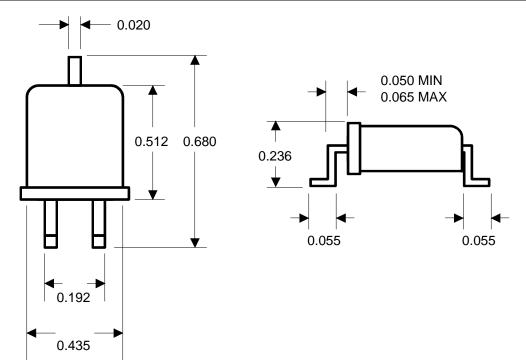
5. Due to tighter total frequency range tolerances, the CXT8192A must be placed within 0.5 inches of device crystal pins and cut-outs should be made in power and ground planes beneath the crystal traces to minimize parasitic capacitance.

General Specifications & Package Dimensions

Mode	Fundamental	0.435
Drive Level	2 mW (max)	
Aging	5 ppm/yr. (max)	
Shock	10 G's, 6 ms, 6 planes	
Vibration	5 G's, 10 Hz to 500 Hz	
Seal Leaks	10 ⁻⁸ cc/sec in Helium	0.530
Solderability	per Mil. std. 202, method 208 (no preconditioning, RMA flux)	
Thermal Shock	5 cycles, -55 to 125 °C, 1/2 cycle/hr. in air	0.500 min
Series Resistance (CXT6176,CXT8192	40 Ω (max) at 50 μW power	
Series Resistance for CXT8192A	60 Ω (max) at 50 μW power	0.192
	•	All mossurements are in inches

All measurements are in inches Package identifier: HC-49





All measurements are in inches Package identifier: HC-49U/N